



REPORT No. : SZ17100006E02

FCC TEST REPORT

APPLICANT : Huawei Technologies Co., Ltd.

PRODUCT NAME : Virtual Reality Handle

MODEL NAME : CF20

TRADE NAME : N/A

BRAND NAME : HUAWEI

STANDARD(S) : 47 CFR Part 15 Subpart B

TEST DATE : 2017-10-15 to 2017-10-20

ISSUE DATE : 2017-10-23

SHENZHEN MORLAB COMMUNICATIONS TECHNOLOGY Co., Ltd.

NOTE: This document is issued by MORLAB, the test report shall not be reproduced except in full without prior written permission of the company. The test results apply only to the particular sample(s) tested and to the specific tests carried out which is available on request for validation and information confirmed at our website.

MORLAB GROUP

FL1-3, Building A, FeiYang Science Park, No.8 LongChang Road,
Block67, BaoAn District, ShenZhen , Guangdong Province, P. R. China

Tel: 86-755-36698555 Fax: 86-755-36698525
Http://www.morlab.cn E-mail: service@morlab.cn



DIRECTORY

<u>1. TECHNICAL INFORMATION</u>	<u>4</u>
1.1. APPLICANT INFORMATION	4
1.2. EQUIPMENT UNDER TEST (EUT) DESCRIPTION	4
<u>2. TEST RESULTS</u>	<u>5</u>
2.1. APPLIED REFERENCE DOCUMENTS	5
<u>3. TEST CONDITIONS SETTING</u>	<u>6</u>
3.1. TEST MODE	6
3.2. TEST SETUP AND EQUIPMENTS LIST	7
3.2.1. RADIATED EMISSION	7
<u>4. 47 CFR PART 15B REQUIREMENTS</u>	<u>9</u>
4.1. RADIATED EMISSION	9
4.1.1. REQUIREMENT	9
4.1.2. TEST DESCRIPTION	9
4.1.3. FREQUENCY RANGE OF MEASUREMENT	9
4.1.4. TEST RESULT	10
<u>ANNEX A TEST SETUP PHOTOS</u>	<u>13</u>
<u>ANNEX B TEST UNCERTAINTY</u>	<u>14</u>
<u>ANNEX C TESTING LABORATORY INFORMATION</u>	<u>15</u>
1. IDENTIFICATION OF THE RESPONSIBLE TESTING LABORATORY	15
2. IDENTIFICATION OF THE RESPONSIBLE TESTING LOCATION	15
3. ACCREDITATION CERTIFICATE	15
4. TEST ENVIRONMENT CONDITIONS	15



Test Report Declaration

Applicant	Huawei Technologies Co., Ltd.
Applicant Address	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Manufacturer	Huawei Technologies Co., Ltd.
Manufacturer Address	Administration Building, Headquarters of Huawei Technologies Co., Ltd., Bantian, Longgang District, Shenzhen, 518129, P.R.C
Product Name	Virtual Reality Handle
Model Name	CF20
Brand Name	HUAWEI
HW Version	Ver-N
SW Version	huaweivr-v1.3n
Test Standards	47 CFR Part 15 Subpart B
Test Result	PASS

Tested by : Wen Zhichao
Wen Zhichao (Test Engineer)

Approved by : Andy Yeh
Andy Yeh (Technology Director)



1. Technical Information

Note: Provided by applicant

1.1. Applicant Information

Company: Huawei Technologies Co., Ltd.
Address: Administration Building, Headquarters of Huawei Technologies Co., Ltd.,
Bantian, Longgang District, Shenzhen, 518129, P.R.C

1.2. Equipment under Test (EUT) Description

EUT Type:	Virtual Reality Handle
Serial No:	(N/A, marked #1 by test site)
Hardware Version:	Ver-N
Software Version:	huaweivr-v1.3n

Power supply :	Battery	
	Brand Name:	Energizer
	Model No.:	E92
	Serial No.:	(N/A, marked #1 by test site)
	Capacity:	1200mAh
	Rated Voltage:	1.5V

NOTE:

1. The EUT is a Virtual Reality Handle which supports ISM 2.4GHz Bluetooth band.
2. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer.



2. Test Results

2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Result
1	15.107	Conducted Emission	N/A	N/A
2	15.109	Radiated Emission	2017.10.17	PASS

NOTE: The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.



3. Test Conditions Setting

3.1. Test Mode

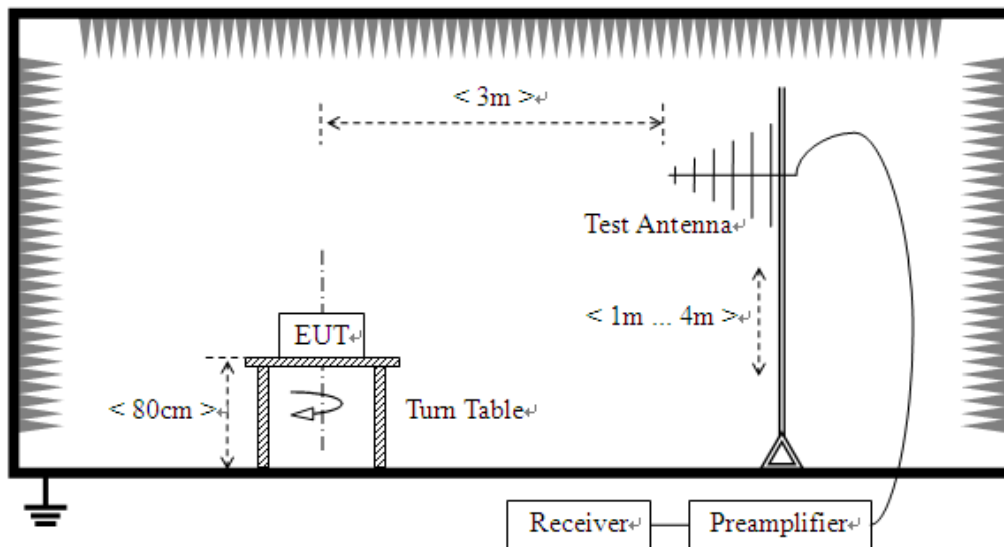
1	The first test mode
	The EUT configuration of the emission tests is EUT + Battery. During the measurement, the Battery was embedded into the EUT and the EUT was kept charging by the Battery, meanwhile, the EUT was working normally as an intentional device.

3.2. Test Setup and Equipments List

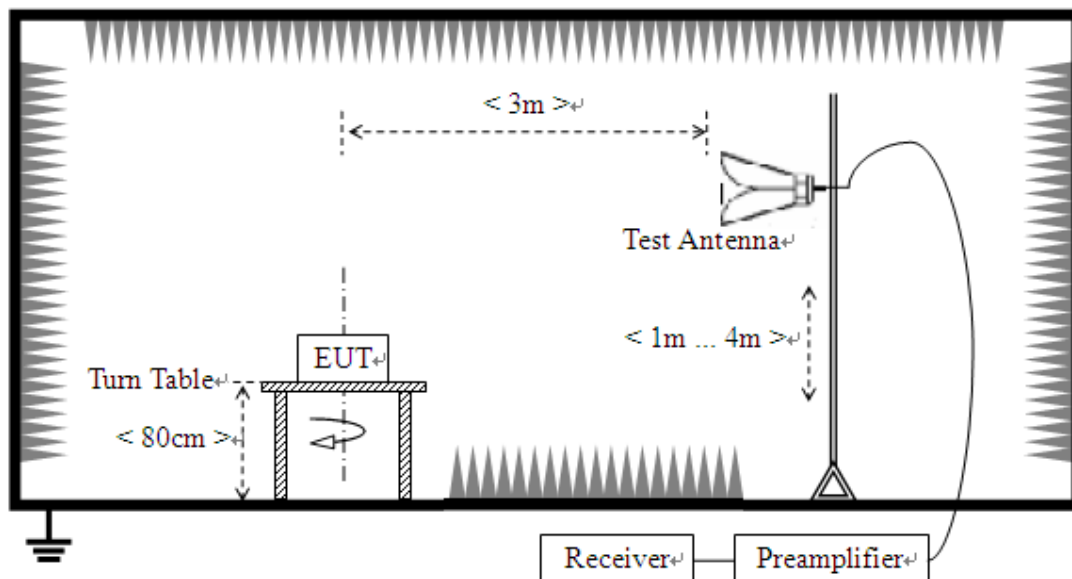
3.2.1. Radiated Emission

A. Test Setup:

1. For radiated emissions from 30MHz to 1GHz



2. For radiated emissions above 1GHz





The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

A. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
MXE EMI Receiver	Agilent	N9038A	MY54130016	2017.05.17	2018.05.16
Semi-Anechoic Chamber	Changning	9m*6m*6m	N/A	2017.01.11	2018.01.10
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-274	2016.12.09	2017.12.08
Test Antenna - Horn	Schwarzbeck	BBHA9120C	9120C-384	2017.03.30	2018.03.29

B. Test Software Utilized

Model	Version Number	Producer
MORLAB EMCR V1.2	Version 1.0	MORLAB

4. 47 CFR Part 15B Requirements

4.1. Radiated Emission

4.1.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength Limitation at 3m Measurement Dist	
	($\mu\text{V/m}$)	(dB $\mu\text{V/m}$)
30.0 - 88.0	100	20log 100
88.0 - 216.0	150	20log 150
216.0 - 960.0	200	20log 200
Above 960.0	500	20log 500

As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dB $\mu\text{V/m}$ is calculated by $20\log$ Emission Level($\mu\text{V/m}$).

4.1.2. Test Description

See section 3.2.2 of this report.

4.1.3. Frequency range of measurement

According to 15.33(b)(1), the frequency range of radiated measurement for the EUT is listed in the



following table:

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 1.705	30.
1.705–108	1000.
108–500	2000.
500–1000	5000.
Above 1000	5th harmonic of the highest frequency or 40 GHz, whichever is lower.

4.1.4. Test Result

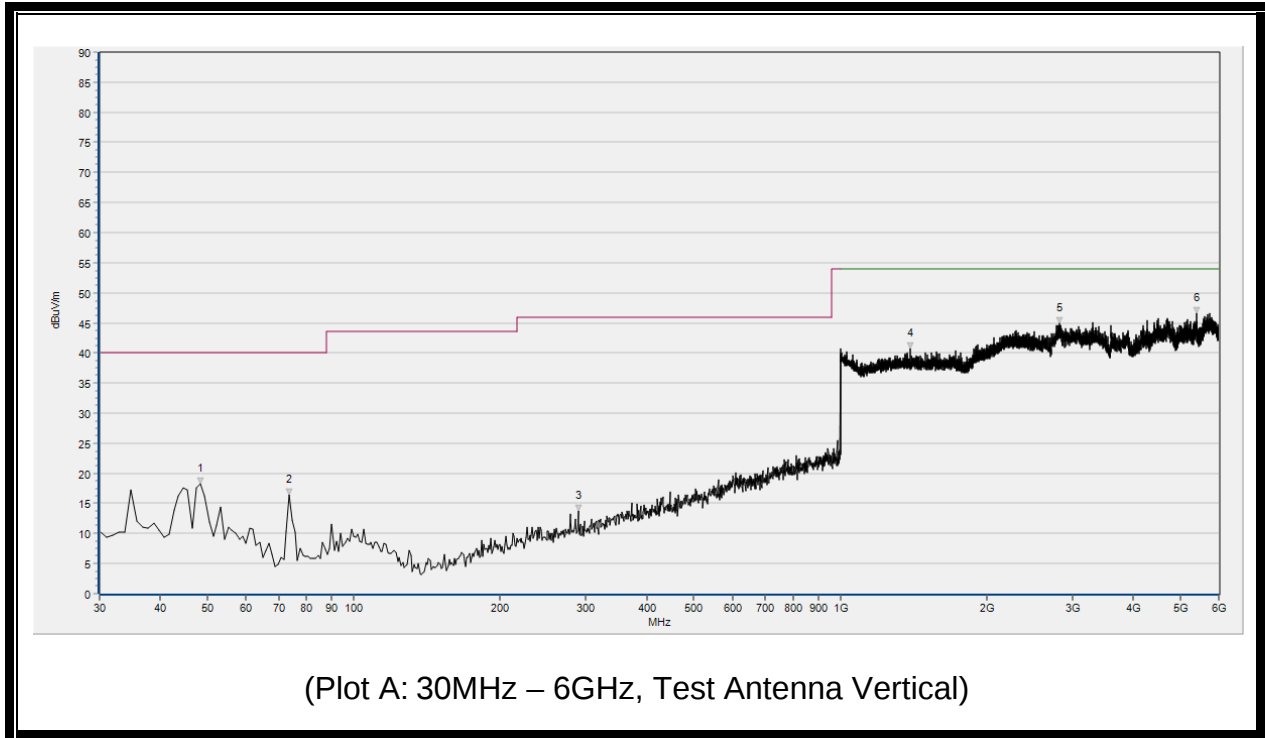
The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions (6GHz-12.5GHz) which are attenuated more than 20 dB below the permissible value need not be reported.

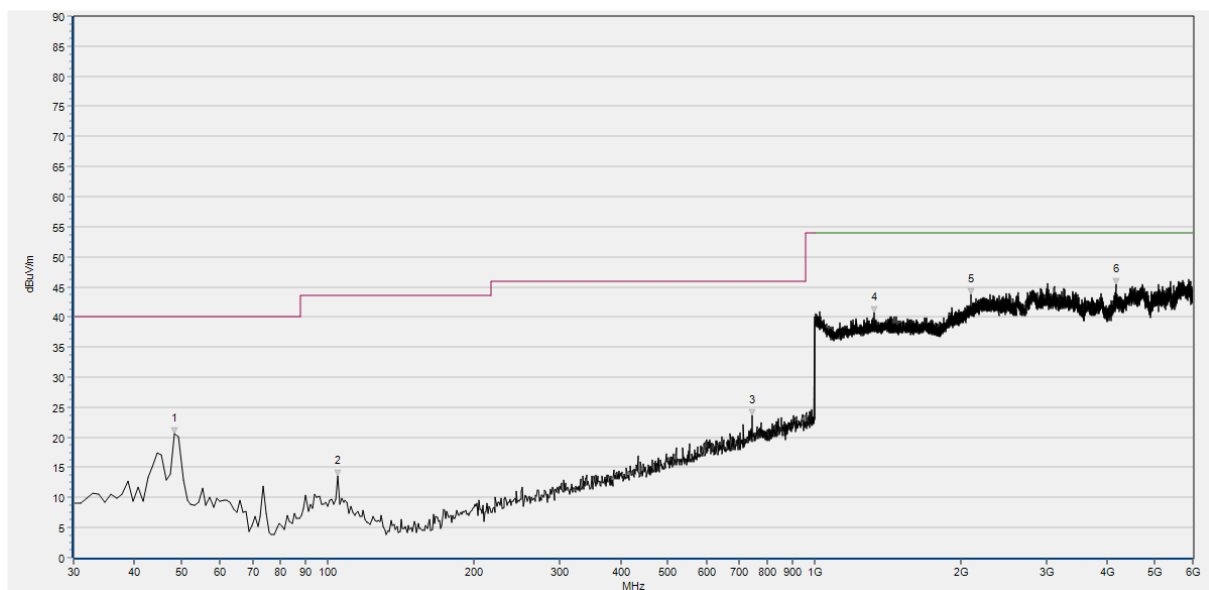
Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.



A. Test Plots and Suspicious Points:



No.	Fre. MHz	Pk dBμV/m	QP dBμV/m	AV dBμV/m	Limit-PK dBμV/m	Limit-QP dBμV/m	Limit-AV dBμV/m	ANT	Verdict
1	48.430	N.A.	18.22	N.A.	N.A.	40.00	N.A.	V	PASS
2	73.650	N.A.	16.50	N.A.	N.A.	40.00	N.A.	V	PASS
3	288.990	N.A.	13.69	N.A.	N.A.	46.00	N.A.	V	PASS
4	1389.867	40.65	N.A.	32.05	70.00	N.A.	54.00	V	PASS
5	2816.080	44.92	N.A.	36.74	70.00	N.A.	54.00	V	PASS
6	5395.720	46.63	N.A.	39.53	74.00	N.A.	54.00	V	PASS



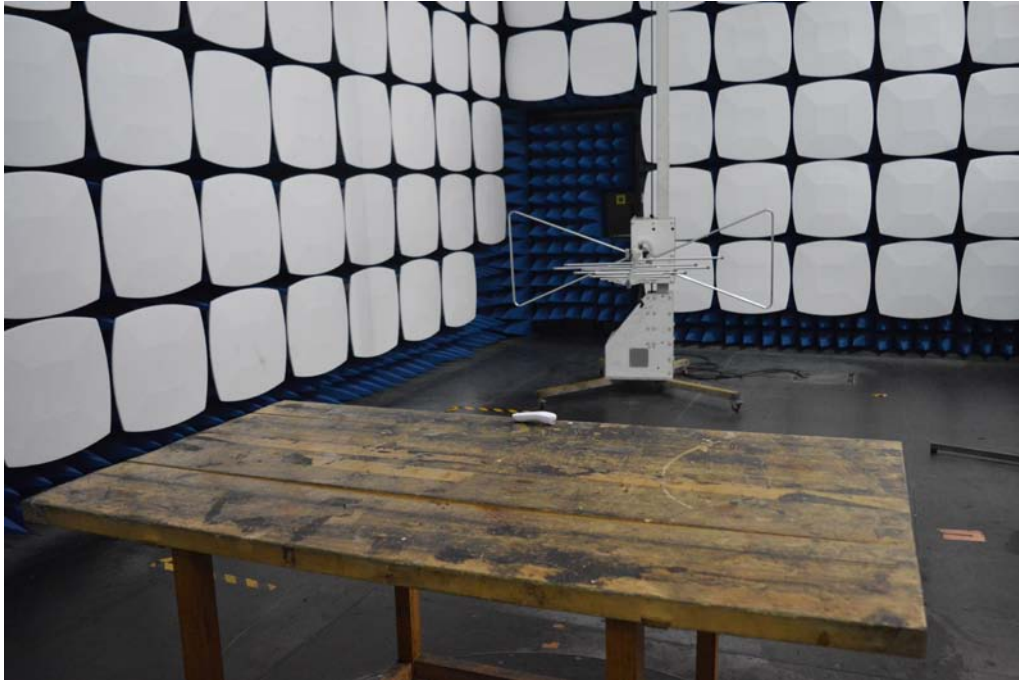
(Plot B: 30MHz – 6GHz, Test Antenna Horizontal)

No.	Fre. MHz	Pk dBμV/m	QP dBμV/m	AV dBμV/m	Limit-PK dBμV/m	Limit-QP dBμV/m	Limit-AV dBμV/m	ANT	Verdict
1	48.430	N.A.	20.56	N.A.	N.A.	40.00	N.A.	H	PASS
2	104.690	N.A.	13.52	N.A.	N.A.	43.50	N.A.	H	PASS
3	744.890	N.A.	23.59	N.A.	N.A.	46.00	N.A.	H	PASS
4	1329.067	40.71	N.A.	32.25	70.00	N.A.	54.00	H	PASS
5	2098.667	43.79	N.A.	36.48	70.00	N.A.	54.00	H	PASS
6	4165.840	45.48	N.A.	37.66	74.00	N.A.	54.00	H	PASS

Result: Pass

Annex A Test Setup Photos

1. Radiated emission (30MHz-1GHz)



2. Radiated emission (above 1GHz)





Annex B Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Radiated Emission:	$\pm 3.1\text{dB}$
-----------------------------------	--------------------



Annex C Testing Laboratory Information

1. Identification of the Responsible Testing Laboratory

Company Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Department:	Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China
Responsible Test Lab Manager:	Mr. Su Feng
Telephone:	+86 755 36698555
Facsimile:	+86 755 36698525

2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China

3. Accreditation Certificate

Accredited Testing Laboratory: The FCC designation number is CN1192.
(Shenzhen Morlab Communications Technology Co., Ltd.)

4. Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106

***** END OF REPORT *****